

International IR Rectifier

PD - 95570

IRG4PH40UD2PbF

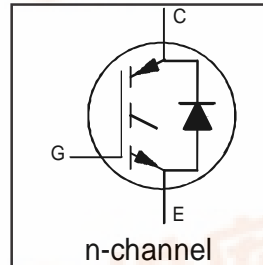
INSULATED GATE BIPOLAR TRANSISTOR WITH UltraFast CoPack IGBT
ULTRAFast SOFT RECOVERY DIODE

Features

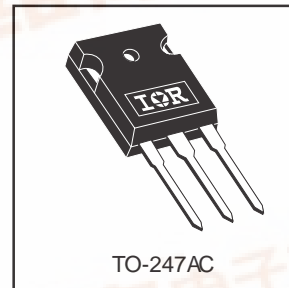
- UltraFast: Optimized for high operating frequencies up to 40 kHz in hard switching, >200 kHz in resonant mode
- New IGBT design provides tighter parameter distribution and higher efficiency than previous generations
- IGBT co-packaged with HEXFRED™ ultrafast, ultra-soft-recovery anti-parallel diodes for use in bridge configurations
- Industry standard TO-247AC package
- Lead-Free

Benefits

- Higher switching frequency capability than competitive IGBTs
- Highest efficiency available
- HEXFRED diodes optimized for performance with IGBT's. Minimized recovery characteristics require less/no snubbing.



$V_{CES} = 600V$
$V_{CE(on)} \text{ typ.} = 1.72V$
@ $V_{GE} = 15V, I_C = 20A$



Absolute Maximum Ratings

	Parameter	Max.	Units
V_{CES}	Collector-to-Emitter Voltage	600	V
$I_C @ T_C = 25^\circ C$	Continuous Collector Current	40	A
$I_C @ T_C = 100^\circ C$	Continuous Collector Current	20	
I_{CM}	Pulse Collector Current ①	160	
I_{LM}	Clamped Inductive Load current ①	160	
$I_F @ T_C = 100^\circ C$	Diode Continuous Forward Current	10	
I_{FM}	Diode Maximum Forward Current	40	
V_{GE}	Gate-to-Emitter Voltage	± 20	V
$P_D @ T_C = 25^\circ C$	Maximum Power Dissipation	160	W
$P_D @ T_C = 100^\circ C$	Maximum Power Dissipation	65	
T_J	Operating Junction and	-55 to +150	°C
T_{STG}	Storage Temperature Range		
	Storage Temperature Range, for 10 sec.	300 (0.063 in. (1.6mm) from case)	
	Mounting Torque, 6-32 or M3 screw	10 lbf•in (1.1N•m)	

Thermal / Mechanical Characteristics

	Parameter	Min.	Typ.	Max.	Units
$R_{\theta JC}$	Junction-to-Case- IGBT	—	—	0.77	°C/W
$R_{\theta JC}$	Junction-to-Case- Diode	—	—	2.5	
$R_{\theta CS}$	Case-to-Sink, flat, greased surface	—	0.24	—	
$R_{\theta JA}$	Junction-to-Ambient, typical socket mount	—	—	40	
Wt	Weight	—	6 (0.21)	—	g (oz.)



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Electrical Characteristics @ T_J = 25°C (unless otherwise specified)

Parameter	Min.	Typ.	Max.	Units	Conditions	
V _{(BR)CES}	600	—	—	V	V _{GE} = 0V, I _C = 250μA	
ΔV _{(BR)CES} /ΔT _J	—	0.63	—	V/°C	V _{GE} = 0V, I _C = 1mA (25°C-150°C)	
V _{CE(on)}	Collector-to-Emitter Saturation Voltage	—	1.72	2.1	V	I _C = 20A, V _{GE} = 15V, T _J = 25°C
		—	2.15	—		I _C = 40A, V _{GE} = 15V, T _J = 125°C
		—	1.7	—		I _C = 20A, V _{GE} = 15V, T _J = 150°C
V _{GE(th)}	3.0	—	6.0		V _{CE} = V _{GE} , I _C = 250μA	
ΔV _{GE(th)} /ΔT _J	—	-13	—	mV/°C	V _{CE} = V _{GE} , I _C = 250μA	
g _{fe}	11	18	—	S	V _{CE} = 100V, I _C = 20A	
I _{CES}	Zero Gate Voltage Collector Current	—	—	250	μA	V _{GE} = 0V, V _{CE} = 600V
		—	—	2.0		V _{GE} = 0V, V _{CE} = 10V, T _J = 25°C
		—	—	2500		V _{GE} = 0V, V _{CE} = 600V, T _J = 150°C
V _{FM}	Diode Forward Voltage Drop	—	3.4	3.8	V	I _F = 10A, V _{GE} = 0V
		—	3.3	3.7		I _F = 10A, V _{GE} = 0V, T _J = 150°C
I _{GES}	Gate-to-Emitter Leakage Current	—	—	±100	nA	V _{GE} = ±20V

Switching Characteristics @ T_J = 25°C (unless otherwise specified)

Parameter	Min.	Typ.	Max.	Units	Conditions	
Q _g	—	110	130	nC	I _C = 20A	
Q _{ge}	—	18	24		V _{CC} = 400V	
Q _{gc}	—	36	53		V _{GE} = 15V	
t _{d(on)}	—	23	—	ns	I _C = 20A, V _{CC} = 600V	
t _r	—	27	—		V _{GE} = 15V, R _G = 10Ω	
t _{d(off)}	—	100	110		T _J = 25°C	
t _f	—	280	340		Energy losses included "tail"	
E _{on}	—	1440	—	μJ	I _C = 20A, V _{CC} = 600V	
E _{off}	—	1410	—		V _{GE} = 15V, R _G = 10Ω	
E _{tot}	—	2850	3740		T _J = 25°C	
t _{d(on)}	—	22	—	ns	I _C = 20A, V _{CC} = 600V	
t _r	—	32	—		V _{GE} = 15V, R _G = 10Ω, L = 1.0mH	
t _{d(off)}	—	190	—		T _J = 150°C	
t _f	—	630	—		Energy losses included "tail"	
E _{TS}	—	5360	—	μJ		
L _E	Internal Emitter Inductance	—	13	nH	Measured 5mm from package	
C _{ies}	Input Capacitance	—	2100	pF	V _{GE} = 0V	
C _{oes}	Output Capacitance	—	99		V _{CC} = 30V	
C _{res}	Reverse Transfer Capacitance	—	12		f = 1.0MHz	
t _{rr}	Diode Reverse Recovery Time	—	50	76	ns	T _J =25°C, V _{CC} =200V, I _F =10A, di/dt=200A/μs
		—	72	110		T _J =125°C, V _{CC} =200V, I _F =10A, di/dt=200A/μs
I _{rr}	Diode Peak Reverse Recovery Current	—	4.4	7.0	A	T _J =25°C, V _{CC} =200V, I _F =10A, di/dt=200A/μs
		—	5.9	8.8		T _J =125°C, V _{CC} =200V, I _F =10A, di/dt=200A/μs
Q _{rr}	Diode Reverse Recovery Charge	—	130	200	nC	T _J =25°C, V _{CC} =200V, I _F =10A, di/dt=200A/μs
		—	250	380		T _J =125°C, V _{CC} =200V, I _F =10A, di/dt=200A/μs
di _{(rec)M} /dt	Diode Peak Rate of Fall of Recovery During t _b	—	210	—	A/μs	T _J =25°C, V _{CC} =200V, I _F =10A, di/dt=200A/μs
		—	180	—		T _J =125°C, V _{CC} =200V, I _F =10A, di/dt=200A/μs

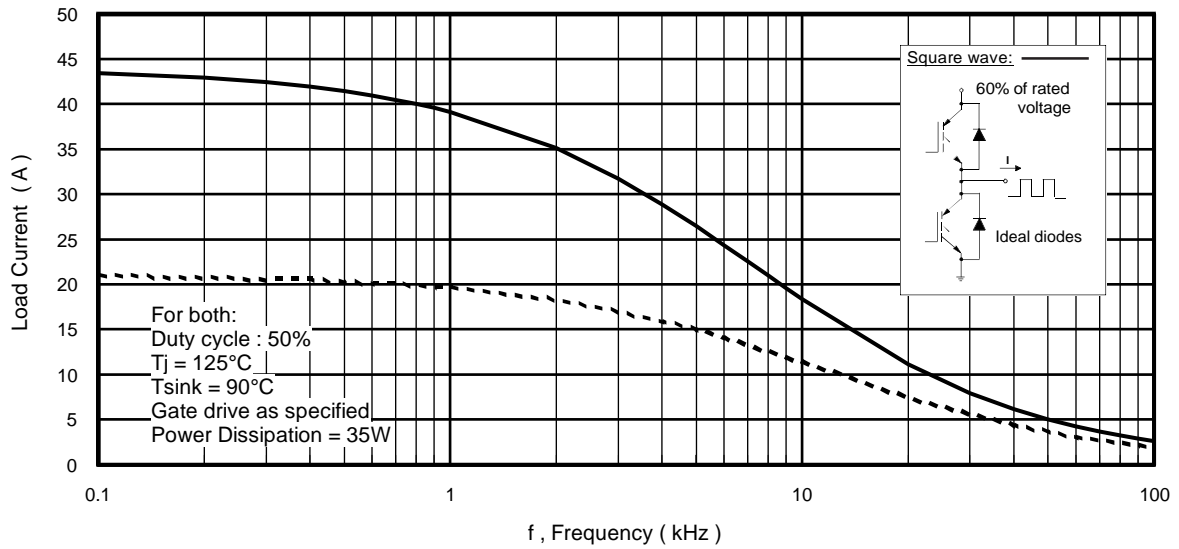


Fig. 1 - Typical Load Current vs. Frequency
(Load Current = I_{RMS} of fundamental)

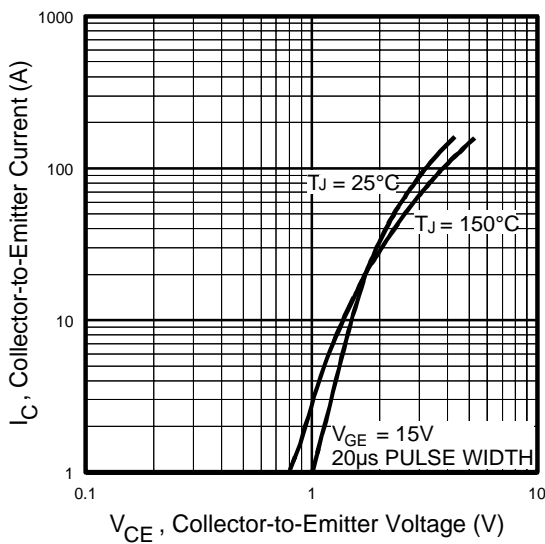


Fig. 2 - Typical Output Characteristics

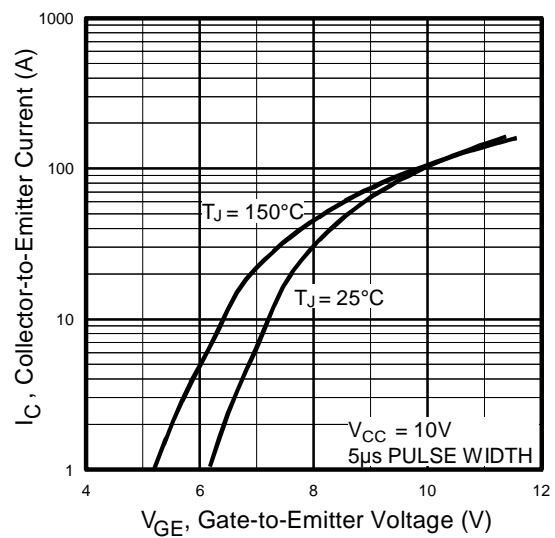


Fig. 3 - Typical Transfer Characteristics

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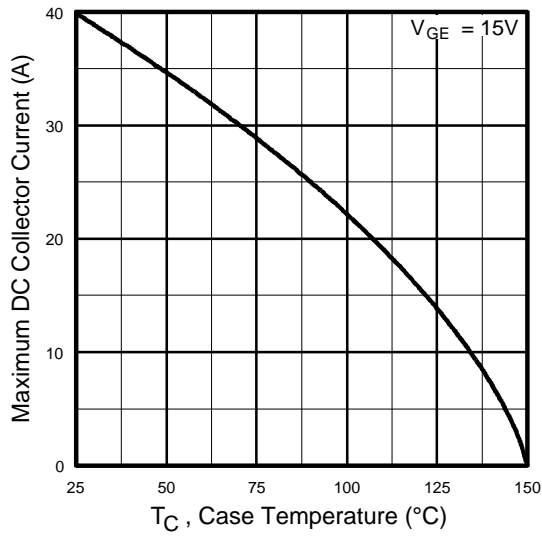


Fig. 4 - Maximum Collector Current vs. Case Temperature

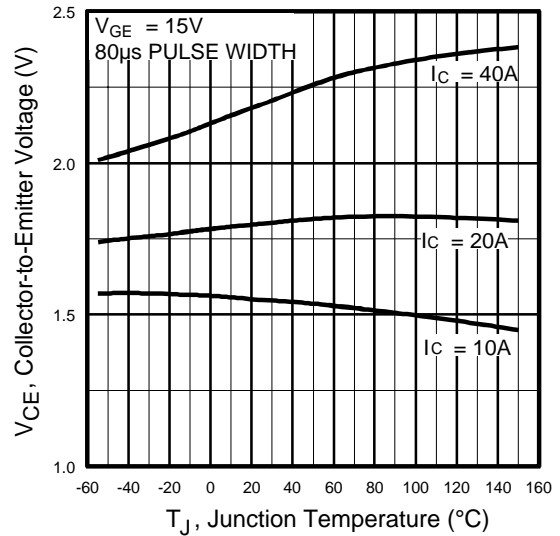


Fig. 5 - Typical Collector-to-Emitter Voltage vs. Junction Temperature

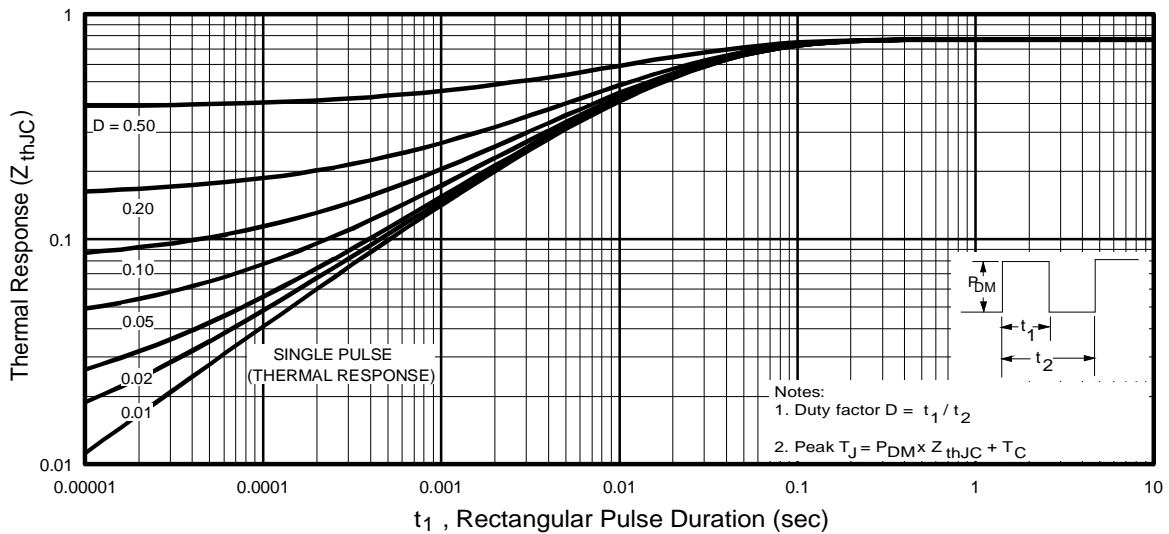


Fig. 6 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

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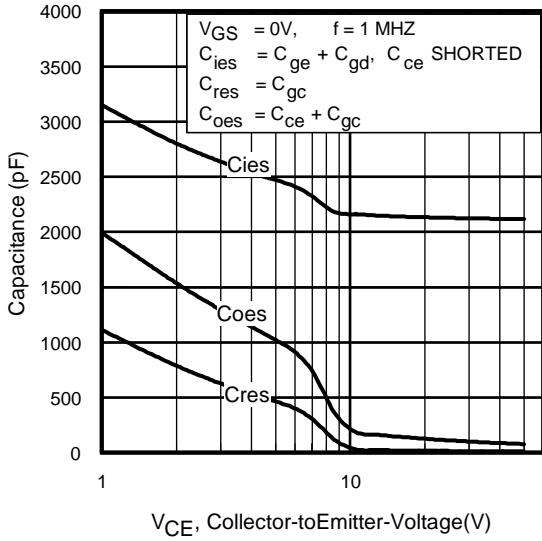


Fig. 7 - Typical Capacitance vs. Collector-to-Emitter Voltage

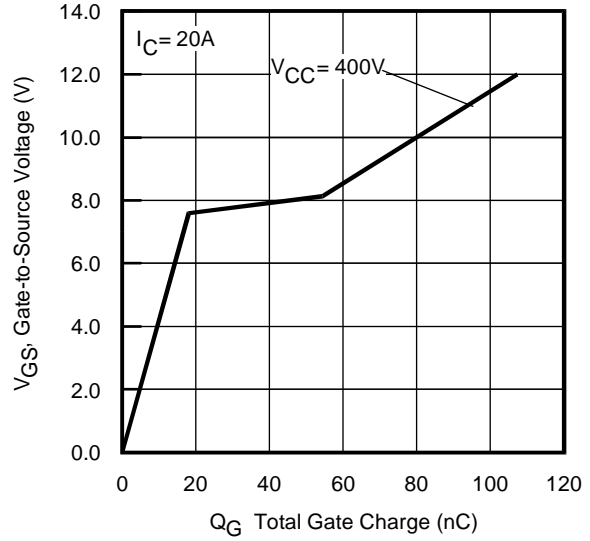


Fig. 8 - Typical Gate Charge vs. Gate-to-Source Voltage

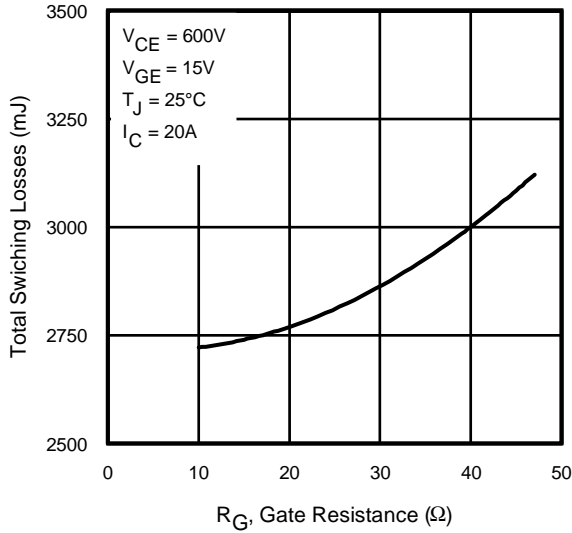


Fig. 9 - Typical Switching Losses vs. Gate Resistance

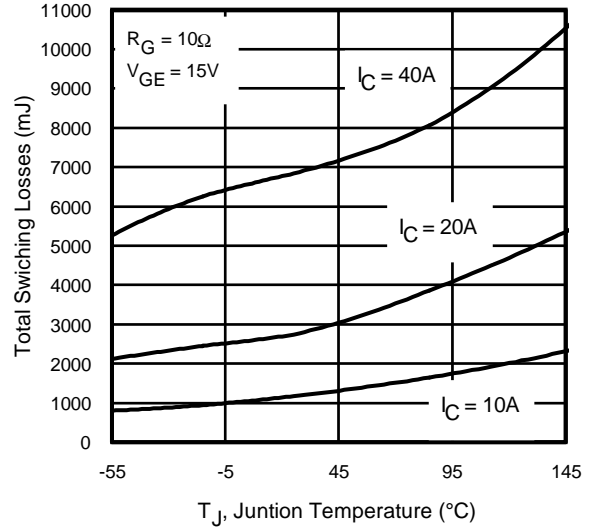


Fig. 10 - Typical Switching Losses vs. Junction Temperature

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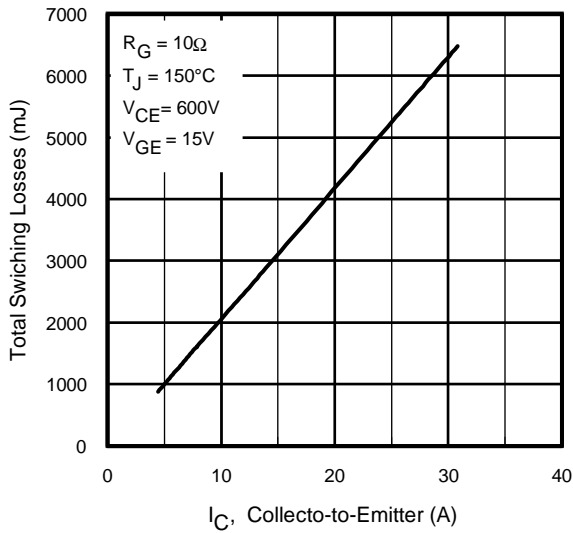


Fig. 11 - Typical Switching Losses vs. Collector-to-Emitter Current

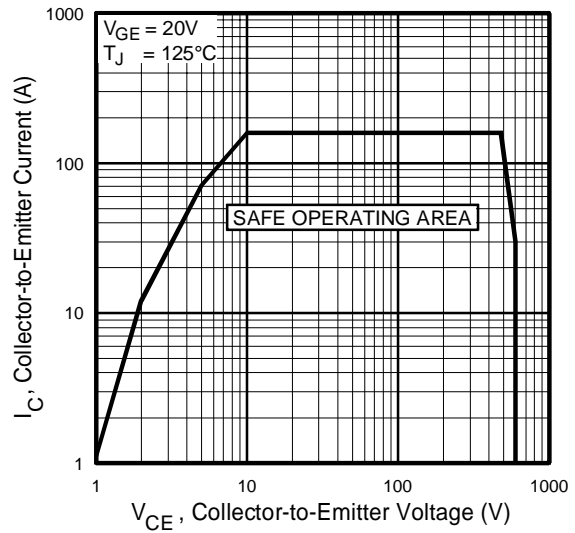


Fig. 12 - Turn-Off SOA

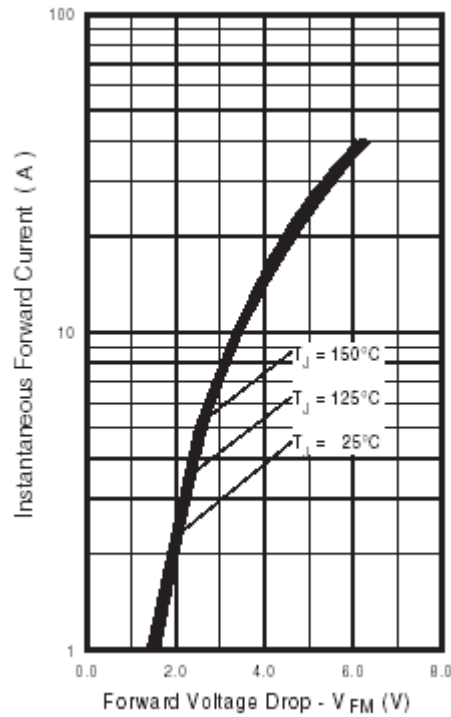


Fig. 13 - Maximum Forward Voltage Drop vs. Instantaneous Forward Current

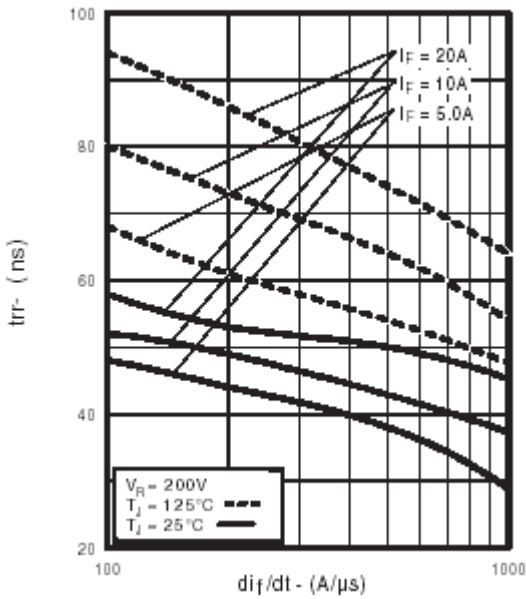


Fig. 14 - Typical Reverse Recovery vs. di_f/dt

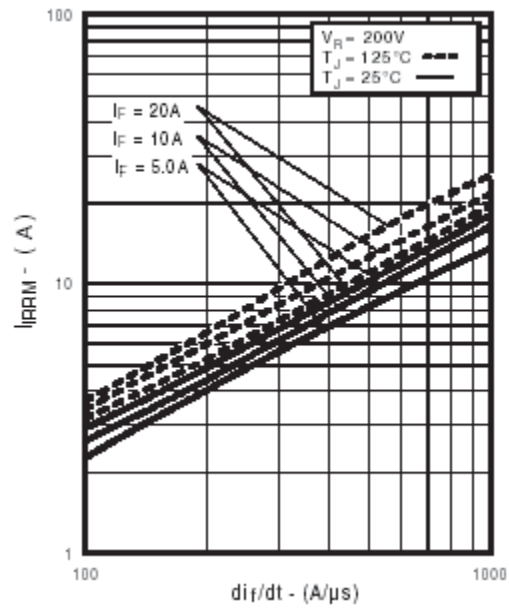


Fig. 15 - Typical Recovery Current vs. di_f/dt

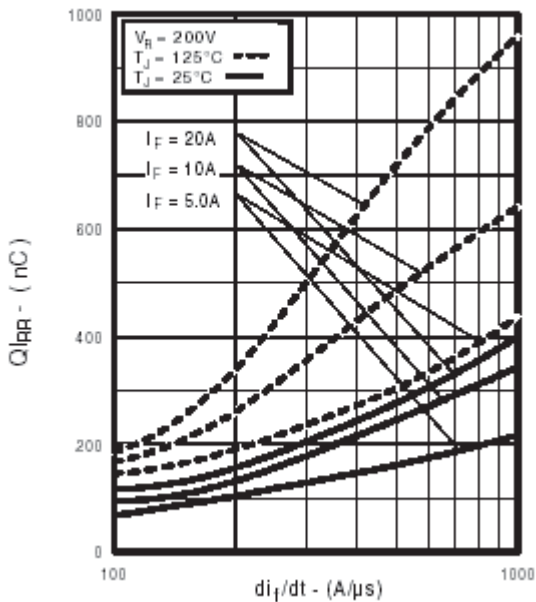


Fig. 16 - Typical Stored Charge vs. di_f/dt

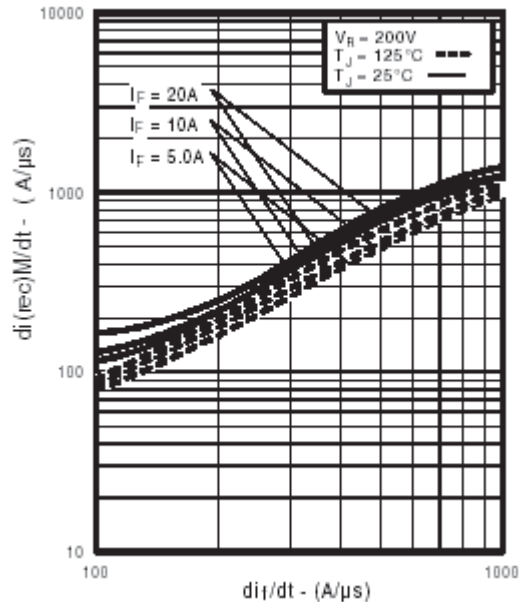


Fig. 17 - Typical $di_{(rec)M}/dt$ vs. di_f/dt

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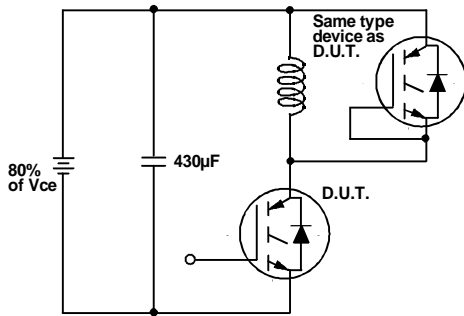


Fig. 18a - Test Circuit for Measurement of I_{LM} , E_{on} , $E_{off(diode)}$, t_{rr} , Q_{rr} , I_{rr} , $t_{d(on)}$, t_r , $t_{d(off)}$, t_f

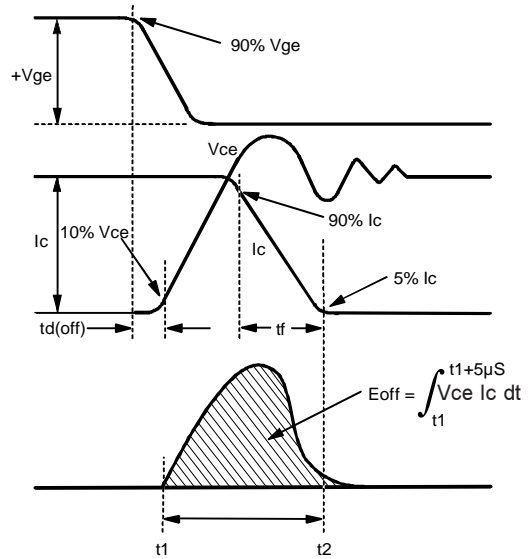


Fig. 18b - Test Waveforms for Circuit of Fig. 18a, Defining E_{off} , $t_{d(off)}$, t_f

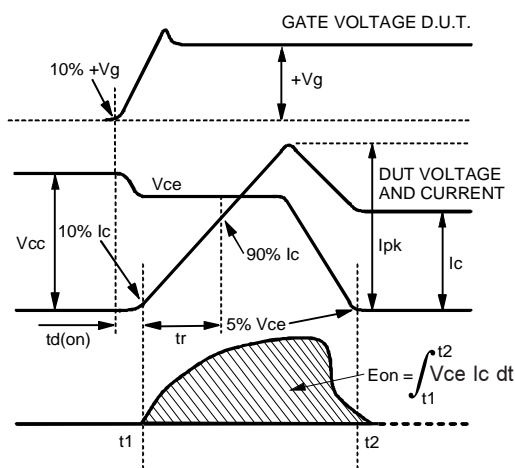


Fig. 18c - Test Waveforms for Circuit of Fig. 18a, Defining E_{on} , $t_{d(on)}$, t_r

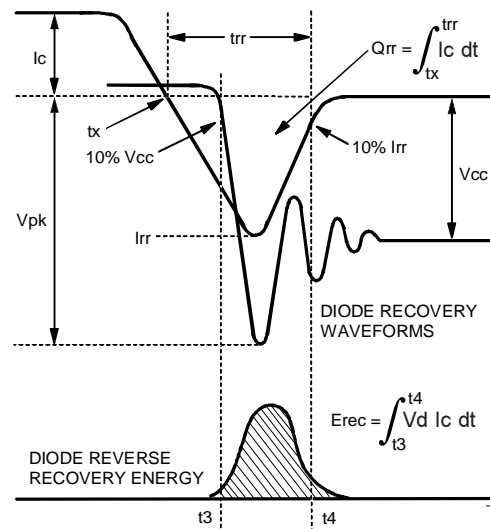


Fig. 18d - Test Waveforms for Circuit of Fig. 18a, Defining E_{rec} , t_{rr} , Q_{rr} , I_{rr}

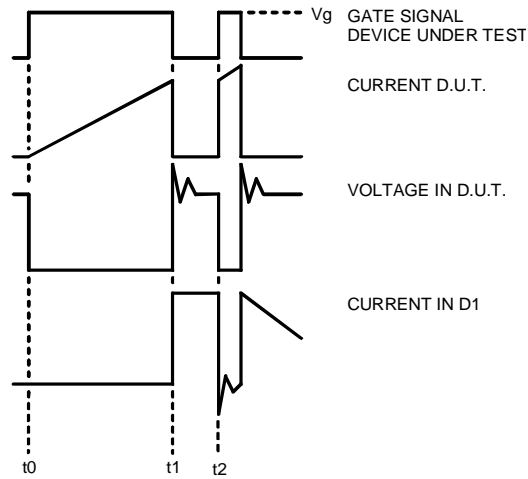


Figure 18e. Macro Waveforms for Figure 18a's Test Circuit

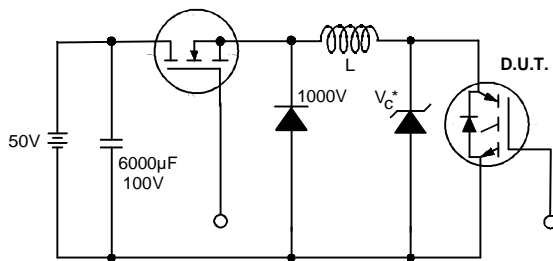


Figure 19. Clamped Inductive Load Test Circuit

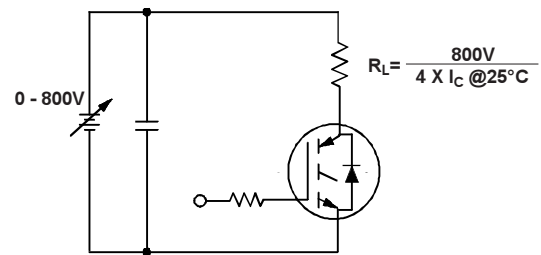


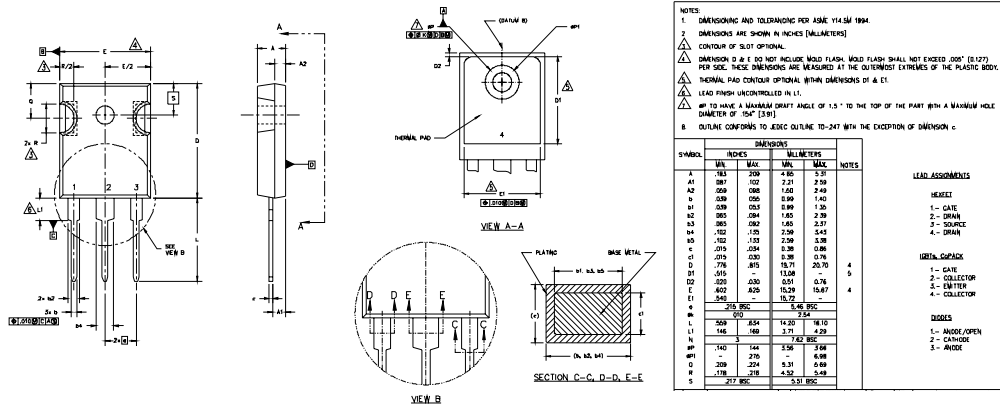
Figure 20. Pulsed Collector Current Test Circuit

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TO-247AC Package Outline

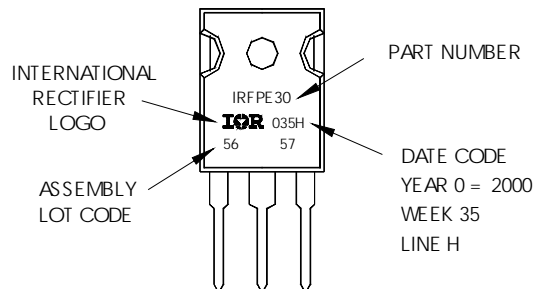
Dimensions are shown in millimeters (inches)



TO-247AC Part Marking Information

EXAMPLE: THIS IS AN IRFPE30
WITH ASSEMBLY
LOT CODE 5657
ASSEMBLED ON WW 35, 2000
IN THE ASSEMBLY LINE "H"

Note: "P" in assembly line
position indicates "Lead-Free"



Notes:

- Repetitive rating: $V_{GE}=20V$; pulse width limited by maximum junction temperature (figure 20)
- $V_{CC}=80\%(V_{CES})$, $V_{GE}=20V$, $L=10\mu H$, $R_G=10\Omega$ (figure 19)
- Pulse width $\leq 80\mu s$; duty factor $\leq 0.1\%$.
- Pulse width $5.0\mu s$, single shot.

TO-247AC package is not recommended for Surface Mount Application.

Data and specifications subject to change without notice.
This product has been designed and qualified for Industrial market.
Qualification Standards can be found on IR's Web site.

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